Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/673,625	NEIER ET AL.	
Examiner	Art Unit	
Steven J. Ganey	3752	

SEARCHED			
Class	Subclass	Date	Examiner
239	661,664, 667,669, 672,673, 679		
	681,682	2/3/06	205
ABOUT	UPDATED		
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239	671	9/10/6	SZ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
INTERF SEARCH PRINTO	ERENCE HISTORY IT	alcolo6	88F

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text and inventorship searched.	2/3/06	557-
	1/10/06	300-
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